Introduction

Choosing a crystal with the correct characteristics is one of the most critical steps in using a Voltage Controlled Crystal Oscillator (VCXO).

VCXO Crystal Selection

The crystal parameters affect the tuning range and accuracy of a VCXO. Below are the key variables and an example of using the crystal parameters to calculate the tuning range of the VCXO.

**Figure 1. VCXO Oscillator Circuit**

![VCXO Oscillator Circuit Diagram](image)

where
- $V_c =$ Control voltage used to tune frequency
- $C_v =$ Varactor capacitance, varies due to the change in voltage control
- $C_{L1}/C_{L2} =$ Load tuning capacitance used for fine tuning or centering nominal frequency
- $C_{S1}/C_{S2} =$ Stray Capacitance caused by pads, vias, and other board parasitics

**Crystal Parameters Example**

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Test Conditions</th>
<th>Minimum</th>
<th>Typical</th>
<th>Maximum</th>
<th>Units</th>
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</thead>
<tbody>
<tr>
<td>$f_N$</td>
<td>Frequency</td>
<td></td>
<td>25</td>
<td>±20 ppm</td>
<td>±20 ppm</td>
<td>MHz</td>
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<tr>
<td>$f_T$</td>
<td>Frequency Tolerance</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td>ppm</td>
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<tr>
<td>$f_S$</td>
<td>Frequency Stability</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td>ppm</td>
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<tr>
<td></td>
<td>Operating Temperature Range</td>
<td></td>
<td>-40</td>
<td>65</td>
<td>85</td>
<td>°C</td>
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<tr>
<td>$C_L$</td>
<td>Load Capacitance</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td>pF</td>
</tr>
<tr>
<td>$C_O$</td>
<td>Shunt Capacitance</td>
<td></td>
<td>Note 1</td>
<td></td>
<td></td>
<td>pF</td>
</tr>
<tr>
<td>$C_O/C_1$</td>
<td>Pullability Ratio</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>$F_{L_{30VLT}}$</td>
<td>3rd Overtone $F_L$</td>
<td></td>
<td>200</td>
<td>220</td>
<td>240</td>
<td>ppm</td>
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<tr>
<td>$F_{L_{30VLT_spurs}}$</td>
<td>3rd Overtone $F_L$ Spurs</td>
<td></td>
<td>200</td>
<td></td>
<td></td>
<td>ppm</td>
</tr>
<tr>
<td>ESR</td>
<td>Equivalent Series Resistance</td>
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<td>20</td>
<td></td>
<td></td>
<td>Ω</td>
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<tr>
<td>Drive Level</td>
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<td>1</td>
<td></td>
<td></td>
<td>mW</td>
</tr>
<tr>
<td>Aging @ 25 °C</td>
<td></td>
<td></td>
<td>±3 per year</td>
<td></td>
<td></td>
<td>ppm</td>
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Varactor Parameters

<table>
<thead>
<tr>
<th>Symbol</th>
<th>Parameter</th>
<th>Typical</th>
<th>Unit</th>
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</thead>
<tbody>
<tr>
<td>CVLOW</td>
<td>Low Varactor Capacitance</td>
<td>15.4 (note 1)</td>
<td>pF</td>
</tr>
<tr>
<td>CVHIGH</td>
<td>High Varactor Capacitance</td>
<td>29.6 (note 1)</td>
<td>pF</td>
</tr>
</tbody>
</table>

Note 1: Refer to the device datasheet for recommended CVLOW and CVHIGH.

Formulas

\[
C_{Low} = \frac{(C_{L1} + C_{S1} + C_{V_{Low}})\cdot(C_{L2} + C_{S2} + C_{V_{Low}})}{(C_{L1} + C_{S1} + C_{V_{Low}})+(C_{L2} + C_{S2} + C_{V_{Low}})}
\]

\[
C_{High} = \frac{(C_{L1} + C_{S1} + C_{V_{High}})\cdot(C_{L2} + C_{S2} + C_{V_{High}})}{(C_{L1} + C_{S1} + C_{V_{High}})+(C_{L2} + C_{S2} + C_{V_{High}})}
\]

- \( C_{Low} \) is the effective capacitance due to the low varactor capacitance, load capacitance and stray capacitance. \( C_{Low} \) determines the high frequency component on the TPR.
- \( C_{High} \) is the effective capacitance due to the high varactor capacitance, load capacitance and stray capacitance. \( C_{High} \) determines the low frequency component on the TPR.

Total Pull Range (TPR) = \[
\frac{1}{2\cdot\frac{C_0}{C_1}\cdot\left(1 + \frac{C_{Low}}{C_0}\right)} - \frac{1}{2\cdot\frac{C_0}{C_1}\cdot\left(1 + \frac{C_{High}}{C_0}\right)} \cdot 10^6
\]

Absolute Pull Range (APR) = Total Pull Range – (Frequency Tolerance + Frequency Stability + Aging)

Example Calculations

Using the tables and figures above, we can now calculate the TPR and APR of the VCXO using the example crystal parameters. For the numerical example below there were some assumptions made. First, the stray capacitance (Cs1, Cs2), which is all the excess capacitance due to board parasitic, is 4pF. Second, the expected lifetime of the project is 5 years; hence the inaccuracy due to aging is ±15ppm. Third, though many boards will not require load tuning capacitors (Cl1, Cl2), it is recommended for long-term consistent performance of the system that two tuning capacitor pads be placed into every design. Typical values for the load tuning capacitors will range from 0 to 4pF.

\[
C_{Low} = \frac{(0 + 4\text{pF} + 15.4\text{pF})\cdot(0 + 4\text{pF} + 15.4\text{pF})}{(0 + 4\text{pF} + 15.4\text{pF})+(0 + 4\text{pF} + 15.4\text{pF})} = 9.7\text{pF}
\]

\[
C_{High} = \frac{(0 + 4\text{pF} + 29.6\text{pF})\cdot(0 + 4\text{pF} + 29.6\text{pF})}{(0 + 4\text{pF} + 29.6\text{pF})+(0 + 4\text{pF} + 29.6\text{pF})} = 16.8\text{pF}
\]

\[
TPR = \frac{1}{2\cdot220\cdot\left(1 + \frac{9.7\text{pF}}{4\text{pF}}\right)} - \frac{1}{2\cdot220\cdot\left(1 + \frac{16.8\text{pF}}{4\text{pF}}\right)} \cdot 10^6 \cdot = 226.5\text{ppm}
\]

\[TPR = \pm 113.25\text{ppm}\]

\[APR = 113.25\text{ppm} - (20\text{ppm} + 20\text{ppm} + 15\text{ppm}) = \pm 58.25\text{ppm}\]

The example above will ensure a total pull range of ±113.25 ppm with an APR of ±58.25ppm. Many times, board designers may select their own crystal based on their application. If the application requires a tighter APR, a crystal with better pull-ability (C0/C1 ratio) can be used. Also, with the equations above, one can vary the frequency tolerance, temperature stability, and aging or shunt capacitance to achieve the required pull-ability.
Recommended Vendors

Some of the Voltage controlled crystal oscillators devices from IDT require a pull-able crystal. There are VCXO’s designed by IDT which do not require a pull-able crystal. The Crystal parameters for the VCXO’s are in the datasheet. Most crystal manufactures, given the crystal specifications can manufacture a reliable crystal to work with IDT VCXO’s. If there are any comments or concerns, please contact IDT.
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